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Application Number

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First Named Inventor

Art Unit

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Attorney Docket Number

100 / 530 159

October 8, 2003

Dror Shemesh

6317P004D
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## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>				Application Number	
				10/530159	
				Filing Date	October 8, 2003
				First Named Inventor	Dror Shemesh
				Art Unit	
Examiner Name					
Attorney Docket Number				6317P004D	
Sheet	2	of	2		

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No.†	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
/Z.H./		International Search Report, PCT/US2003/03237, 03/18/2004, 5pp	
/Z.H./		WILLICH, P., BETHKE, R., Performance and limitations of electron probe microanalysis applied to the characterization of coatings and layered structures, 1/16/1995, 4pp	

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